

Search Notes



Application No.

10/814,326

Examiner

Hieu Phan

Applicant(s)

BOYLAN ET AL.

Art Unit

3738

SEARCHED

Class	Subclass	Date	Examiner
623	1.15 - 1.22	12/12/2004	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR